

ELEG 5633 Detection and Estimation

Kullback-Leibler (KL) Divergence

Jingxian Wu

Department of Electrical Engineering
University of Arkansas

Outline

- ▶ Motivation: LLR of i.i.d. Samples
- ▶ Kullback-Leibler Divergence
- ▶ KL Divergence of Gaussian Distributions
- ▶ Bounding Error Probabilities

Motivation

Example

Consider a binary Hypothesis:

$$H_1 : X \sim p_1(X)$$

$$H_0 : X \sim p_0(X)$$

Based on a sequence of independent observations x_1, x_2, \dots, x_n , design the ML test.

Log-likelihood Ratio (LLR) of Independent Samples

Consider a sequence of independent and identically distributed (i.i.d.) random variables (RVs) $X_1, X_2, \dots, X_n \sim p_m(x)$, for $m \in \{0, 1\}$. For a given observation $x = [x_1, x_2, \dots, x_n]$

- ▶ Likelihood ratio

$$L(x) = \frac{p_1(x_1, x_2, \dots, x_n)}{p_0(x_1, x_2, \dots, x_n)} = \prod_{i=1}^n \frac{f_1(x_i)}{f_0(x_i)}$$

- ▶ Log-likelihood ratio (LLR)

$$\log L(x) = \sum_{i=1}^n \log \frac{p_1(x_i)}{p_0(x_i)}$$

- ▶ Normalized LLR

$$\Lambda(x) = \frac{1}{n} \sum_{i=1}^n \log \frac{p_1(x_i)}{p_0(x_i)}$$

Since x is a random vector, $\Lambda(x)$ is a random variable.

Convergence of Normalized LLR

- ▶ Strong Law of Large Numbers

Consider a sequence of i.i.d. RV X_1, X_2, \dots with $\mathbb{E}(X_i) = \mu$. Then the sample mean, $\bar{x}_n := \frac{1}{n} \sum_{i=1}^n x_i$, converges to the expected value μ **almost surely (a.s.)** as $n \rightarrow \infty$,

$$\bar{x}_n = \frac{1}{n} \sum_{i=1}^n x_i \xrightarrow{\text{a.s.}} \mu, \text{ when } n \rightarrow \infty$$

which means $\Pr(\lim_{n \rightarrow \infty} \bar{x}_n = \mu) = 1$.

- ▶ Convergence of $\Lambda(x)$: Assume $X \sim q(x)$. Then as $n \rightarrow \infty$,

$$\Lambda(x) = \frac{1}{n} \sum_{i=1}^n \log \frac{p_1(x_i)}{p_0(x_i)} \xrightarrow{\text{a.s.}} \mathbb{E}_q \left[\log \frac{p_1(X)}{p_0(X)} \right], \text{ when } n \rightarrow \infty$$

where $q(x)$ could be the same or different as $p_m(x)$.

Kullback-Leibler (KL) Divergence

The KL divergence between from distribution $p_1(x)$ to $p_0(x)$ is

$$D(p_1 \| p_0) = \mathbb{E}_{p_1} \left[\log \frac{p_1(X)}{p_0(X)} \right] \quad (1)$$

- ▶ Continuous RV

$$D(p_1 \| p_0) = \int \log \frac{p_1(x)}{p_0(x)} p_1(x) dx$$

- ▶ Discrete RV

$$D(p_1 \| p_0) = \sum_k \log \frac{P_1(X = x_k)}{P_0(X = x_k)} P_1(X = x_k)$$

- ▶ KL divergence measures the **non-symmetric** difference between $p_1(x)$ and $p_0(x)$
 - ▶ Note that $D(p_1 \| p_0) \neq D(p_0 \| p_1)$ in general

Example

Consider Bernoulli distributions $P_m \sim \text{Bernoulli}(\rho_m)$, for $m = 0, 1$. Find $D(P_1 \| P_0)$ and $D(P_0 \| P_1)$.

KL Divergence Properties

- ▶ **Gibb's inequality**

$$D(p_1 \| p_0) \geq 0$$

Proof: Jensen's inequality: $\mathbb{E}[\log(X)] \leq \log(\mathbb{E}(X))$

$$\begin{aligned} D(p_1 \| p_0) &= \mathbb{E}_{p_1} \left[\log \frac{p_1(x)}{p_0(x)} \right] = -\mathbb{E}_{p_1} \left[\log \frac{p_0(x)}{p_1(x)} \right] \\ &\geq -\log \left(\mathbb{E}_{p_1} \left[\frac{p_0(x)}{p_1(x)} \right] \right) \\ &= -\log \left(\int \frac{p_0(x)}{p_1(x)} p_1(x) dx \right) = -\log(1) = 0 \end{aligned}$$

- ▶ $D(p_1 \| p_0) = 0$ if and only if (iff) $p_1(x) = p_0(x)$

Example

Consider a binary Hypothesis: $H_1 : X \sim p_1(X)$ and $H_0 : X \sim p_0(X)$. Based on a sequence of i.i.d. observations x_1, x_2, \dots, x_n , design the LRT.

- ▶ The ML test is

$$\Lambda(x) = \frac{1}{n} \sum_{i=1}^n \log \frac{p_1(x_i)}{p_0(x_i)} \underset{H_0}{\overset{H_1}{\geq}} \frac{1}{n} \log \lambda$$

- ▶ When $n \rightarrow \infty$, $\frac{1}{n} \log \lambda \rightarrow 0$
 - ▶ $H_1 : \Lambda(x|H_1) \xrightarrow{a.s.} E_{p_1} \left[\log \frac{p_1(X)}{p_0(X)} \right] = D(p_1 || p_0) \geq 0$.
Thus $P_{MD} \rightarrow 0$ as $n \rightarrow \infty$
 - ▶ $H_0 : \Lambda(x|H_0) \xrightarrow{a.s.} E_{p_0} \left[\log \frac{p_1(X)}{p_0(X)} \right] = -D(p_0 || p_1) \leq 0$
Thus $P_{FA} \rightarrow 0$ as $n \rightarrow \infty$

KL Divergence of Gaussian Distributions

Example

Find the KL divergence from $p_1 \sim \mathcal{N}(\mu_1, \sigma^2)$ to $p_0 \sim \mathcal{N}(\mu_0, \sigma^2)$

Answer:
$$D(p_1 \| p_0) = \frac{(\mu_1 - \mu_0)^2}{2\sigma^2}$$

KL divergence of multivariate Gaussian RV

The KL divergence from $p_1 \sim \mathcal{N}(\mu_1, \Sigma_1)$ to $p_0 \sim \mathcal{N}(\mu_0, \Sigma_0)$ is

$$D(p_1 \| p_0) = \frac{1}{2} \left[\text{tr}(\Sigma_0^{-1} \Sigma_1) + (\mu_0 - \mu_1)^T \Sigma_0^{-1} (\mu_0 - \mu_1) - n + \log \left(\frac{\det \Sigma_0}{\det \Sigma_1} \right) \right]$$

where n is the dimension of the RV.

► Special Cases:

- If $\Sigma_0 = \Sigma_1$, then

$$D(p_1 \| p_0) = \frac{1}{2} (\mu_0 - \mu_1)^T \Sigma_0^{-1} (\mu_0 - \mu_1) = D(p_0 \| p_1)$$

- If $\mu_0 = \mu_1$, then

$$D(p_1 \| p_0) = \frac{1}{2} \left[\text{tr}(\Sigma_0^{-1} \Sigma_1) - n + \log \left(\frac{\det \Sigma_0}{\det \Sigma_1} \right) \right]$$

Example

Consider a binary Hypothesis: $H_1 : X \sim \mathcal{N}(\mu_1, \sigma^2 \mathbf{I}_n)$ and $H_0 : X \sim \mathcal{N}(\mu_0, \sigma^2 \mathbf{I}_n)$. where X is an n dimensional vector. Find the ML detector and P_e .

Solution:

- ML test:

$$-\|x - \mu_1\|^2 \underset{H_0}{\overset{H_1}{\gtrless}} -\|x - \mu_0\|^2$$

$$y = (\mu_1 - \mu_0)^T x \underset{H_0}{\overset{H_1}{\gtrless}} \frac{1}{2}(\mu_1^T \mu_1 - \mu_0^T \mu_0) = \lambda$$

- $y|H_i \sim \mathcal{N}(\mu_{y|H_i}, \sigma_{y|H_i}^2)$

$$\mu_{y|H_0} = (\mu_1 - \mu_0)^T \mu_0, \quad \sigma_{y|H_0}^2 = \sigma^2 \|\mu_1 - \mu_0\|^2$$

- $P_{\text{FA}} = \Pr(y > \lambda | H_0) = Q\left(\frac{\lambda - \mu_{y|H_0}}{\sigma \|\mu_1 - \mu_0\|}\right) = Q\left(\frac{\|\mu_1 - \mu_0\|}{2\sigma}\right) =$
 $Q\left(\sqrt{\frac{\|\mu_1 - \mu_0\|^2}{4\sigma^2}}\right) = Q\left(\sqrt{\frac{1}{2}D(p_1 \| p_0)}\right)$

$$P_e = \pi_0 P_{\text{FA}} + \pi_1 P_{\text{MD}} = Q\left(\sqrt{\frac{1}{2}D(p_1 \| p_0)}\right)$$

Example

Consider a binary Hypothesis:

$$H_0 : X \sim \mathcal{N}(a_0, \sigma^2)$$

$$H_1 : X \sim \mathcal{N}(a_1, \sigma^2)$$

Where X is a scalar. If we have n i.i.d. observations x_1, x_2, \dots, x_n , find the ML detector and P_e .

► Solution: Let $\mu_i = [a_i, a_i, \dots, a_i]^T$

$$P_e = Q\left(\sqrt{\frac{\|\mu_1 - \mu_0\|^2}{4\sigma^2}}\right) = Q\left(\sqrt{\frac{n(a_1 - a_0)^2}{4\sigma^2}}\right) = Q\left(\sqrt{\frac{n}{2}D(p_1\|p_0)}\right)$$

$$\text{where } D(p_1\|p_0) = \frac{(a_1 - a_0)^2}{2\sigma^2}$$

Can we get P_e if X is non-Gaussian distributed?

Bounding Error Probabilities

Hoeffding's Inequality

If Z_1, Z_2, \dots, Z_n are i.i.d. and $a \leq Z_i \leq b$, then

$$\Pr \left(\frac{1}{n} \sum_{i=1}^n Z_i - \mathbb{E}[Z] > \epsilon \right) \leq e^{-\frac{2n\epsilon^2}{c^2}}$$

$$\Pr \left(\mathbb{E}[Z] - \frac{1}{n} \sum_{i=1}^n Z_i > \epsilon \right) \leq e^{-\frac{2n\epsilon^2}{c^2}}$$

where $c^2 = (b - a)^2$.

Bounding Error Probabilities

Theorem

Consider a binary Hypothesis: $H_1 : X \sim p_0(X)$ and $H_0 : X \sim p_1(X)$. Assume $0 < \alpha \leq p_i(x) \leq \beta < \infty$, for $i = 0, 1$. Based on a sequence of i.i.d. observations X_1, X_2, \dots, X_n , then for ML test

$$P_{\text{FA}} \leq \exp\left(-\frac{2}{c^2}nD^2(p_0\|p_1)\right)$$

$$P_{\text{MD}} \leq \exp\left(-\frac{2}{c^2}nD^2(p_1\|p_0)\right)$$

where $c^2 = 4 \log^2 \frac{\beta}{\alpha}$.

Sketch of Proof

- ▶ Let $Z_i = \log \frac{p_1(X_i)}{p_0(X_i)}$, $\Lambda_n = \frac{1}{n} \sum_{i=1}^n Z_i$. The ML test is $\Lambda_n \underset{H_0}{\overset{H_1}{>}} 0$
- ▶ $\mathbb{E}[Z_i|H_0] = -D(p_0||p_1)$, $\mathbb{E}[Z_i|H_1] = D(p_1||p_0)$
- ▶

$$\begin{aligned} P_{\text{FA}} &= \Pr(\Lambda_n > 0|H_0) = \Pr(\Lambda_n - \mathbb{E}[Z_i|H_0] > -\mathbb{E}[Z_i|H_0]|H_0) \\ &\leq \exp\left(-\frac{2}{c^2}nD^2(p_0||p_1)\right) \end{aligned}$$

where $c^2 = (b - a)^2 = \left(\log \frac{\beta}{\alpha} - \log \frac{\alpha}{\beta}\right)^2 = 4 \log^2 \frac{\beta}{\alpha}$

▶

$$\begin{aligned} P_{\text{MD}} &= \Pr(\Lambda_n < 0|H_1) = \Pr(\Lambda_n - \mathbb{E}[Z_i|H_1] < -\mathbb{E}[Z_i|H_1]|H_1) \\ &\leq \exp\left(-\frac{2}{c^2}nD^2(p_1||p_0)\right) \end{aligned}$$

Example

Consider a binary hypothesis:

$$H_0 : X \sim \text{Bernoulli}(0.3)$$

$$H_1 : X \sim \text{Bernoulli}(0.5)$$

- ▶ Find $D(P_1 \| P_0)$ and $D(P_0 \| P_1)$
- ▶ Based on a sequence of i.i.d. observations x_1, \dots, x_n , design the ML test
- ▶ What is the upper bound of P_{FA} ?
- ▶ How many i.i.d. samples do we need to achieve $P_{\text{FA}} < 0.1$?

Solution:



$$D(P_1 \| P_0) = \mathbb{E}_1 \left[\log \frac{P_1(X)}{P_0(X)} \right] = 0.5 \log \frac{0.5}{0.3} + 0.5 \log \frac{0.5}{0.7} = 0.0872$$

$$D(P_0 \| P_1) = \mathbb{E}_0 \left[\log \frac{P_1(X)}{P_0(X)} \right] = 0.3 \log \frac{0.3}{0.5} + 0.7 \log \frac{0.7}{0.5} = 0.0823$$

► Under H_0 : $0.3 \leq \Pr(X = x_i | H_0) \leq 0.7$

Under H_1 : $\Pr(X = x_i | H_1) = 0.5$

Thus $0.3 \leq \Pr(X = x_i | H_m) \leq 0.7$, $\alpha = 0.3$, $\beta = 0.7$.

► $c^2 = 4 \log^2 \frac{\beta}{\alpha} = 2.8717$

► $P_{\text{FA}} \leq \exp\left(-\frac{2}{c^2} n D^2(P_0 \| P_1)\right) = \exp(-0.0047n)$



$$\exp(-0.0047n) \leq 0.1 \Rightarrow n \geq \frac{1}{0.0047} |\log 0.1| \approx 490$$